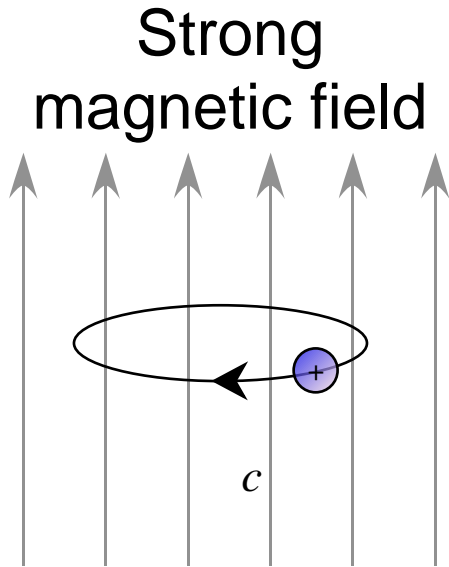

*Towards an
order of magnitude
improvement in
high-precision atomic
mass measurements*

Simon Rainville
James K. Thompson
Prof. David E. Pritchard

Michael P. Bradley
Trey Porto

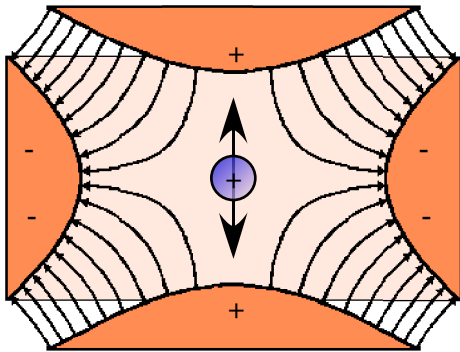
... supported by NSF and NIST.

Single Ion Mass Spectrometry



Cyclotron motion $\omega_c = \frac{qB}{m}$

$$\frac{c_1}{c_2} = \frac{q_1}{q_2} \frac{m_2}{m_1}$$



Harmonic Axial motion $\frac{\omega_z}{2} \approx 200 \text{ kHz}$

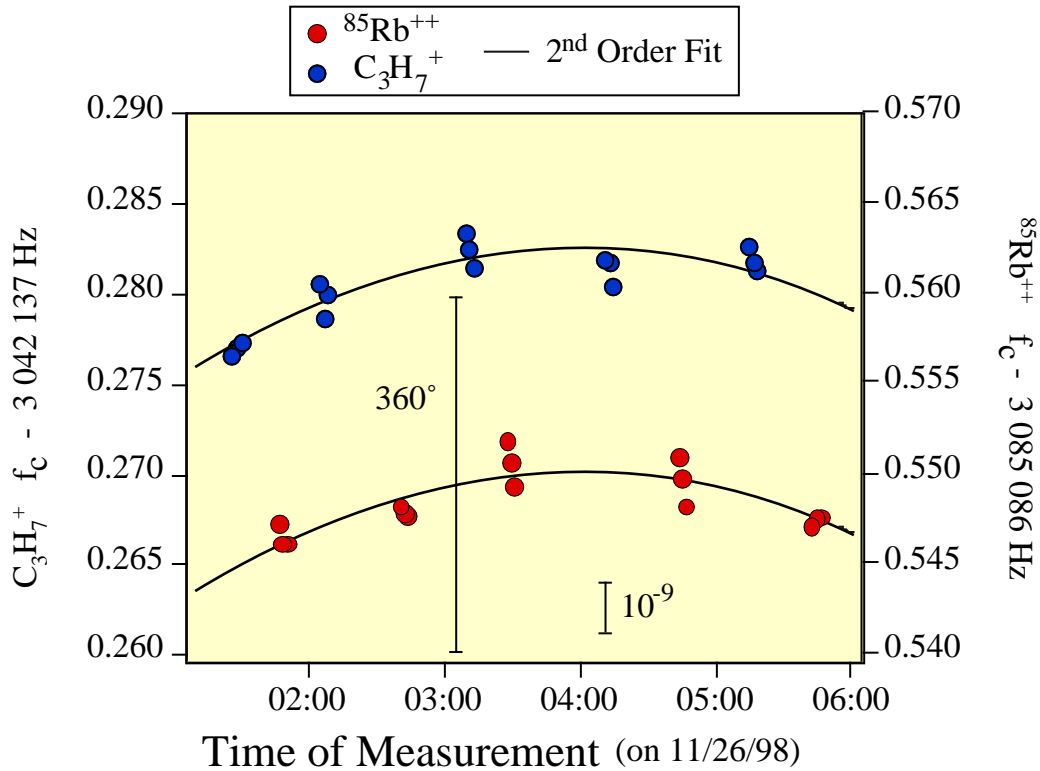
Use mode coupling techniques to measure

$$\frac{\omega_c}{2} \approx 5 \text{ MHz}$$

Slow Magnetron motion
(usually ignore)

$$\frac{\omega_m}{2} \approx 5 \text{ kHz}$$

Single Ion data



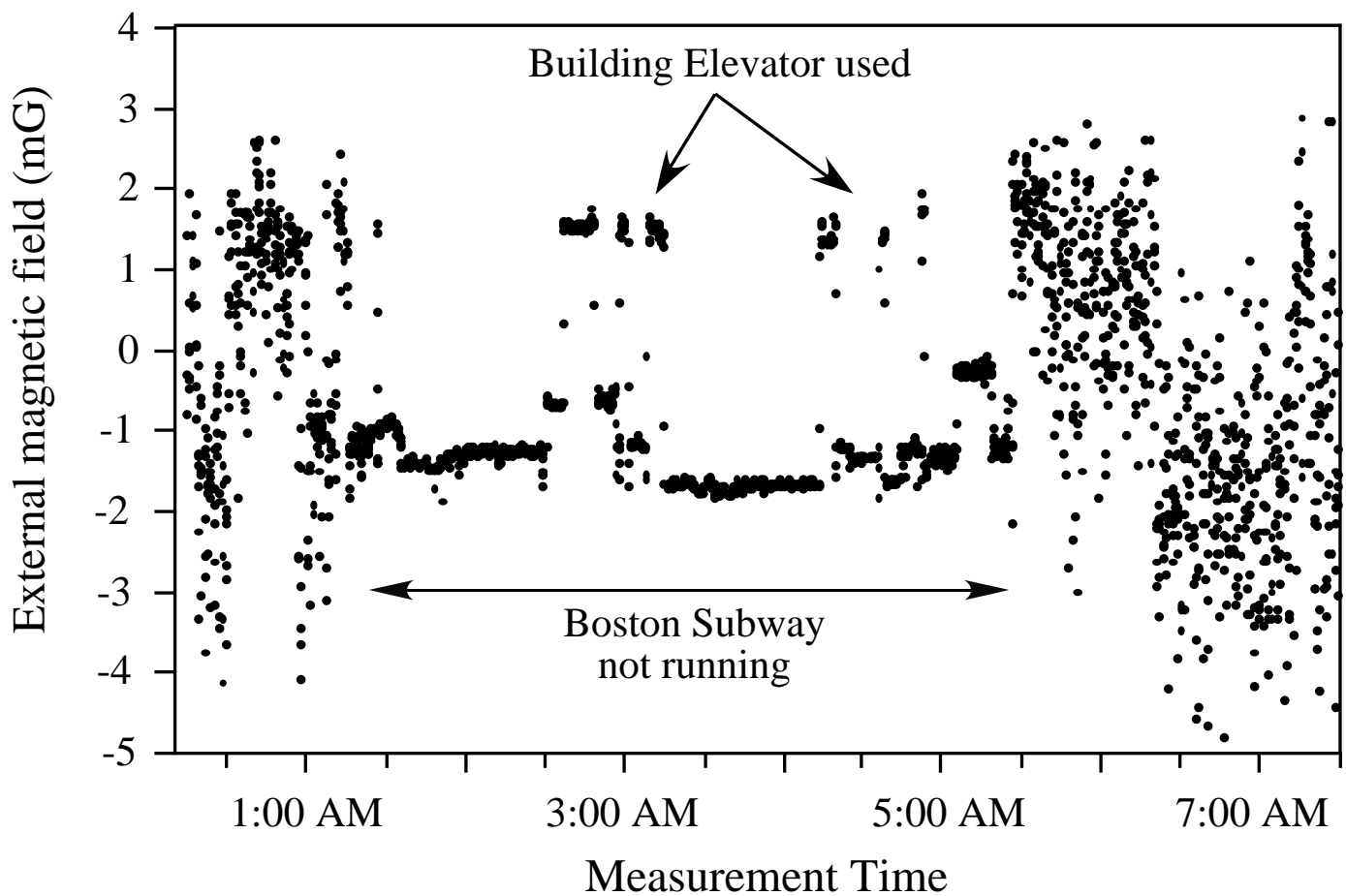
- 5 - 30 minutes to isolate a new single ion
- Precision of 10^{-10} for a full run (4 hours)

MIT Mass Table

Element	m/m ($\times 10^{-10}$)	Factor of improvement	Element	m/m ($\times 10^{-10}$)	Factor of improvement
H	5.0	24	^{23}Na	1.2	93
^2H	2.5	48	^{28}Si	0.7	350
^{13}C	0.8	17	^{40}Ar	0.8	424
^{14}N	0.9	22	^{85}Rb	1.6	193
^{15}N	0.7	36	^{87}Rb	1.7	187
^{16}O	1.3	24	^{133}Cs	2.0	111
^{20}Ne	1.2	957			

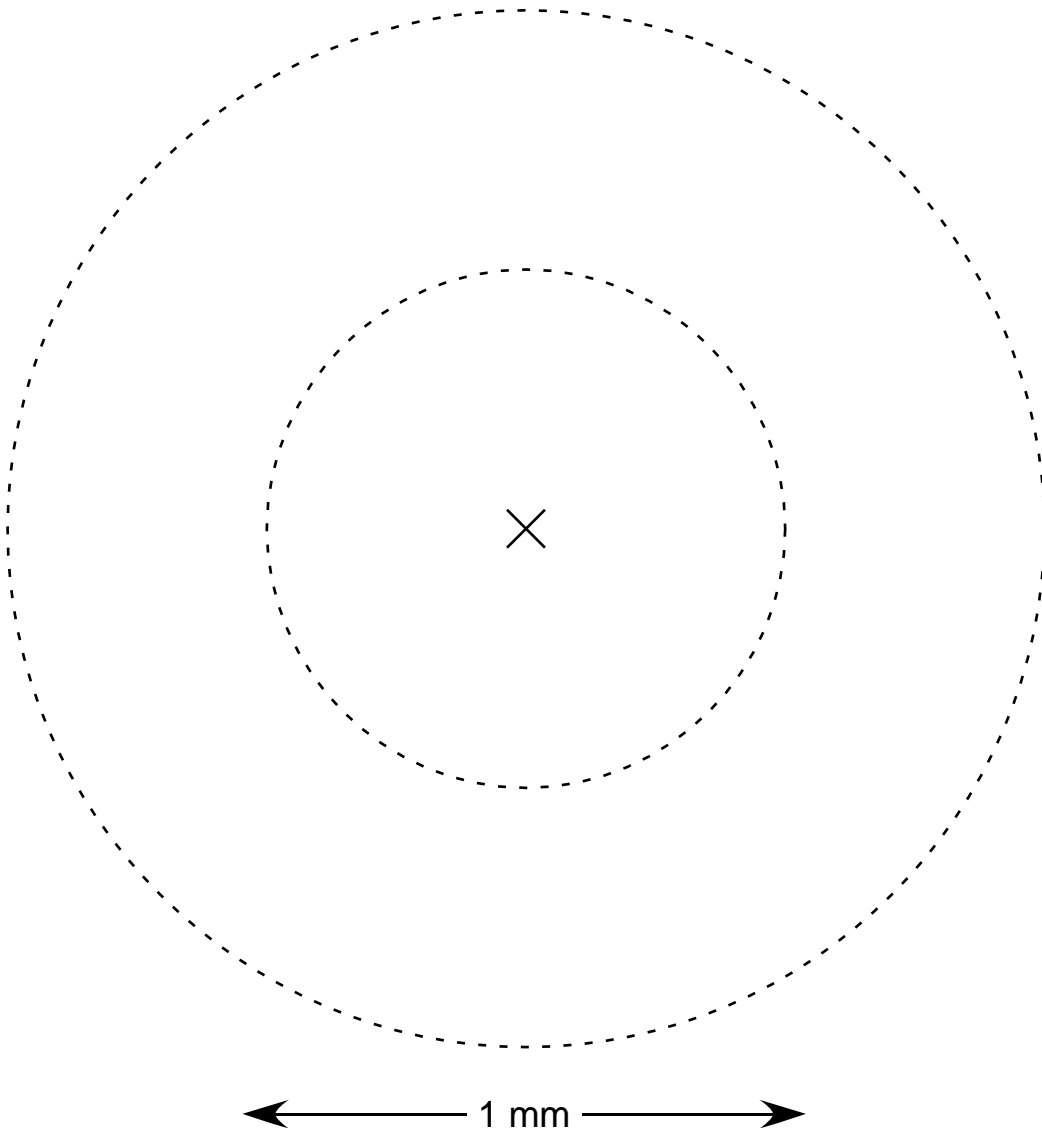
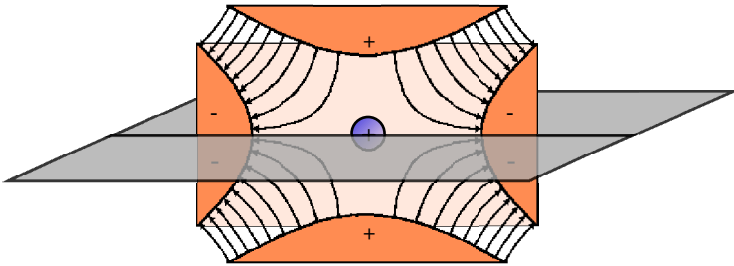
Main Limitation of Single Ion Technique:

Magnetic Field Noise



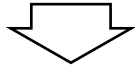
Want to make SIMULTANEOUS measurements

Two Ions in One Trap



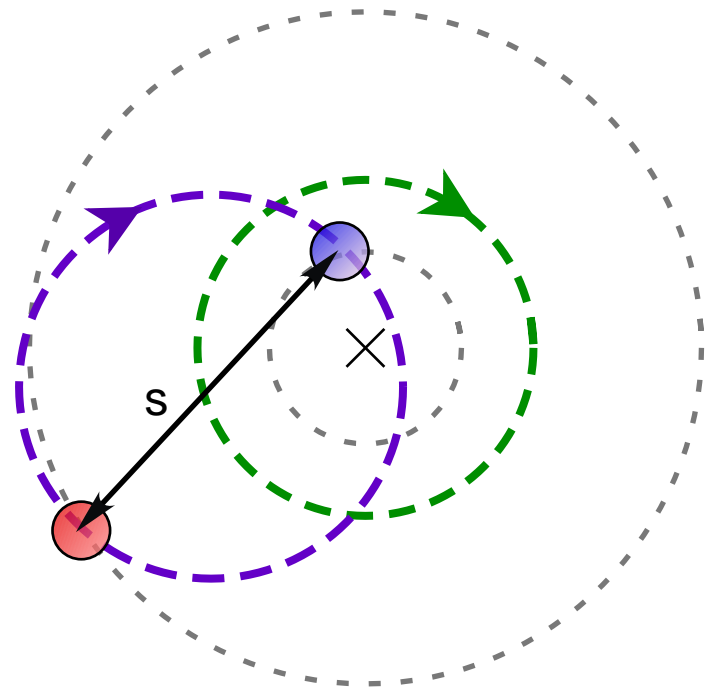
Two Ions in One Trap

m_1 m_2



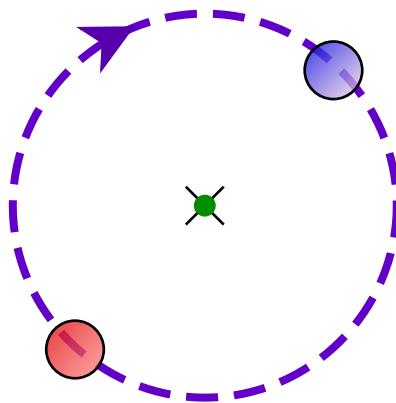
New normal modes:

- center-of-mass
- difference

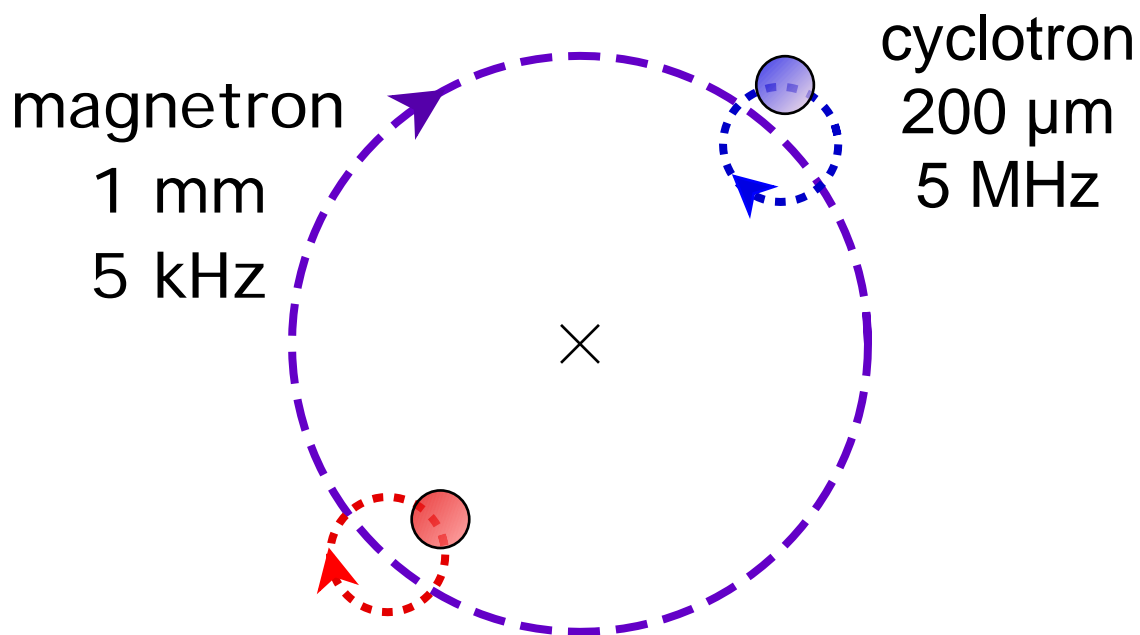
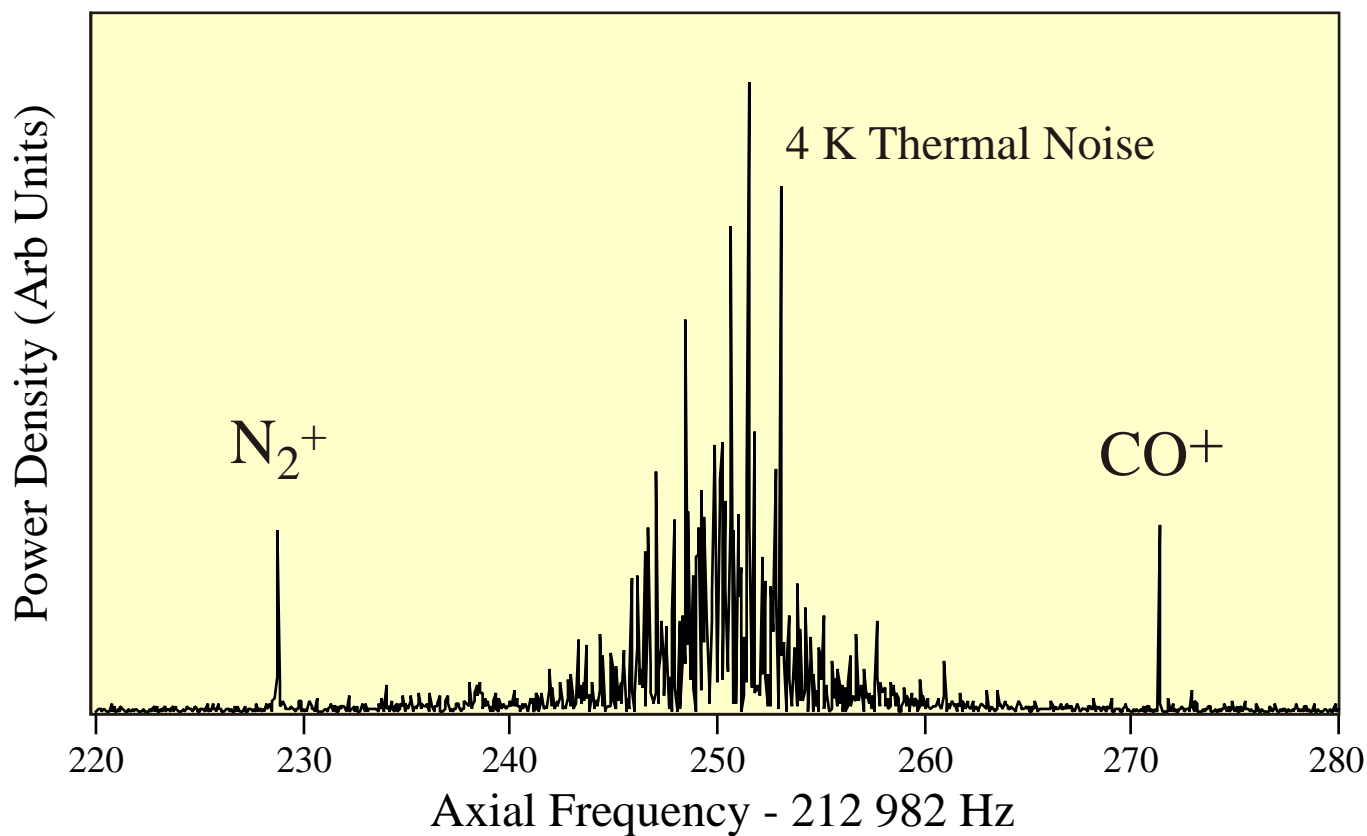


- s is constant
 - s 0.5 - 1 mm
- perturbation $< 2 \times 10^{-12}$ on mass ratio

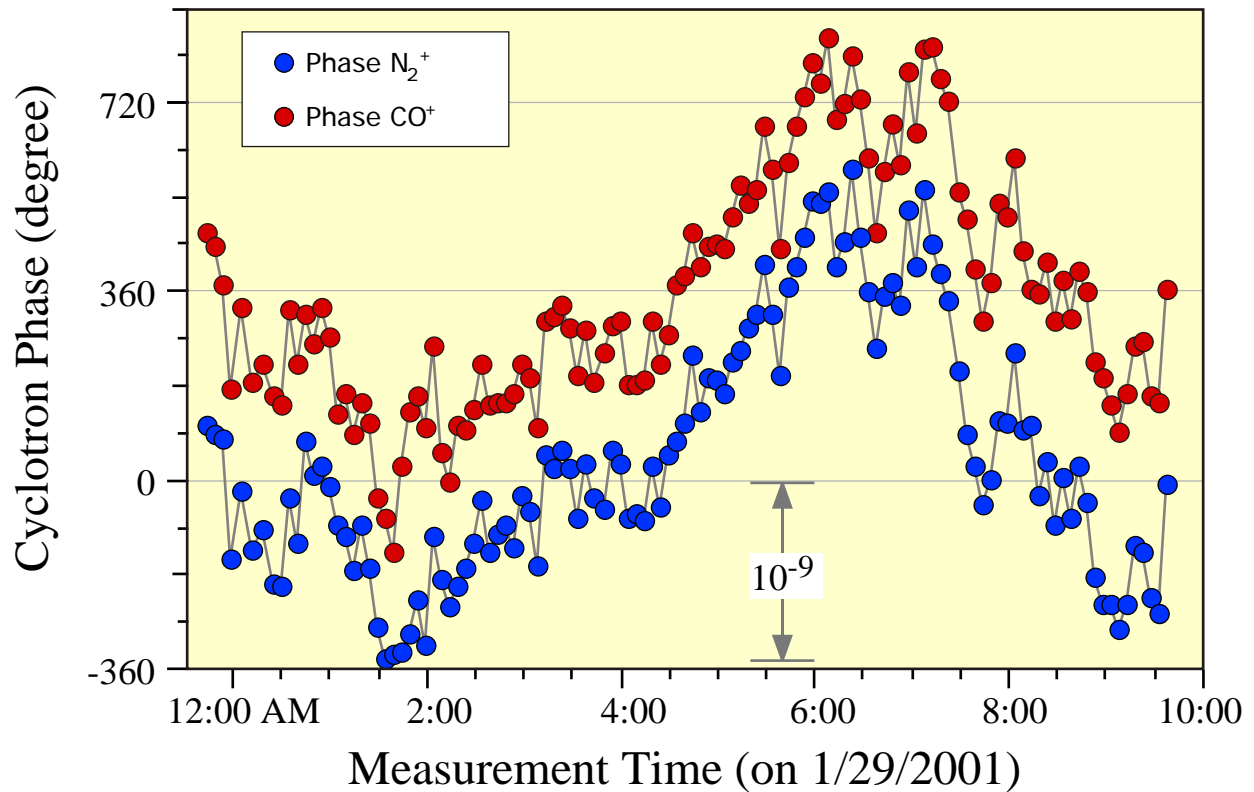
Want $\text{com} = 0$ for the two ions to sample the same average magnetic field.



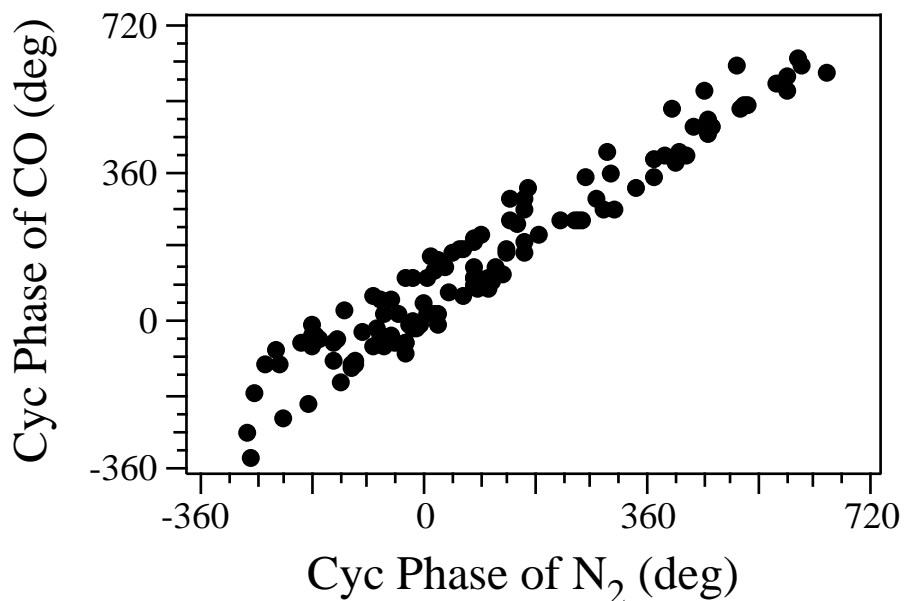
Simultaneous Measurements on Two Ions



Preliminary Two Ions Data



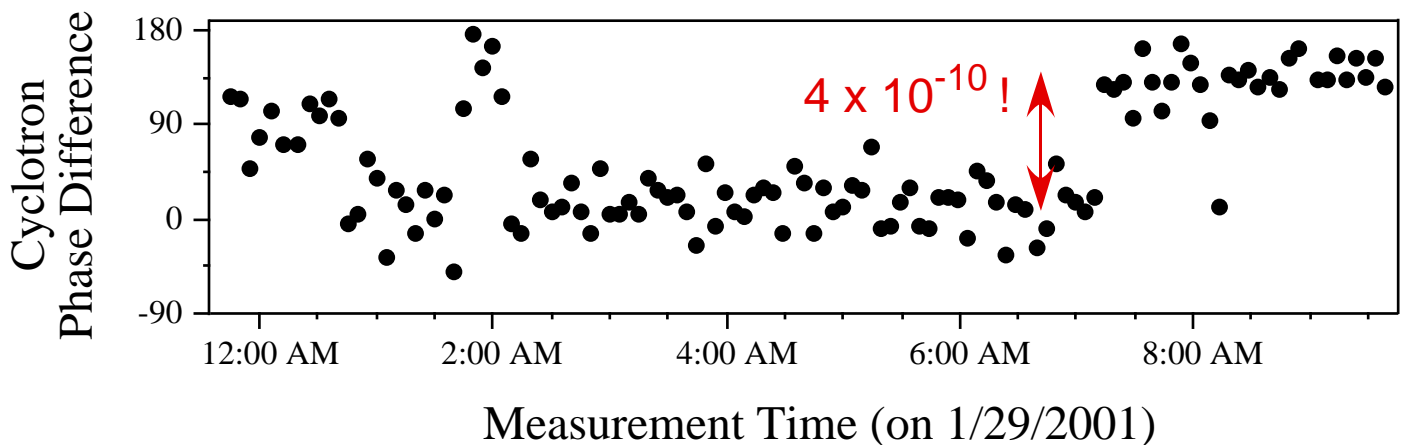
Precision of 10^{-10} in
4 minutes (during the day) !!



Current and Future Work

Big jumps in cyclotron frequency difference:

- ions decouple ?
- change in separation distance ?



Tools to observe and control trajectories of 2 ions:

- Anharmonicities $z(\)$
- Transfer a little bit of mag into axial motion, to measure the ion's radial position.
 - diagnostic
 - fine-tune orbits
 - study possible systematic errors

Simultaneous Measurements on Two Ions

magnetron

1 mm

5 kHz

cyclotron

200 μm

5 MHz

